

Subject card

Subject name and code	Microscopic test methods, PG 00039689								
Field of study	Materials Engineering, Materials Engineering, Materials Engineering								
Date of commencement of	February 2023 Academic year of 2022/2023								
studies	1. 55.4dily 2020		realisation of subject			2022/2023			
Education level	second-cycle studies		Subject group			Optional subject group			
						Subject group related to scientific research in the field of study			
Mode of study	Full-time studies		Mode of delivery			at the university			
Year of study	1		Language of instruction			Polish			
Semester of study	1		ECTS credits			2.0			
Learning profile	general academic profile		Assessment form			assessment			
Conducting unit	Department of Electr	rrosion and Ma	ering ->	Faculty of Chemistry					
Name and surname	Subject supervisor		dr inż. Łukasz Gaweł						
of lecturer (lecturers)	Teachers		dr inż. Łukasz Gaweł						
Lesson types and methods	Lesson type	Lecture	Tutorial	Laboratory	Projec	t	Seminar	SUM	
of instruction	Number of study hours	15.0	0.0	15.0	0.0		0.0	30	
	E-learning hours incl	uded: 0.0	•		•		•		
Learning activity and number of study hours	Learning activity	Participation i classes includ		Participation in consultation hours		Self-study		SUM	
	Number of study hours	30		5.0		15.0		50	
Subject objectives	The goal is to make students familiar with different microscopic techniques: - they should be able to distinguish pros and cons of each technique and capable to select technique for specific task - they should be able to use obtained knowledge for proper imaging of samples - students should know basic parameters related with image quality								
Learning outcomes	Course outcome		Subject outcome			Method of verification			
	K7_K01		Student is capable to correctly choose the measurement tool for a specific need, and ask for help in the analysis and interpretation of test results. He is aware of the development of measurement techniques.			[SK5] Assessment of ability to solve problems that arise in practice			
	K7_W06		Student understands the basic terms and concepts associated with microscopic techniques. Understands the general laws on which the discussed techniques are based. Student is able to choose a technique for a particular need, knows its possibilities and limitations. Knows the development trend of microscopic techniques.			[SW1] Assessment of factual knowledge			
	K7_U06		Student is able to assess the possibility of using new measurement techniques as well as modification of existing techniques in order to increase the obtained analytical information.			[SU4] Assessment of ability to use methods and tools [SU2] Assessment of ability to analyse information			
Subject contents	Lectures: evolution of microscopy techniques, optical microscopy, metalographic, confocal and fluorescent, Raman microscopy, scanning techniques - SEM, STM, AFM and similar, spectroscopic mapping, XPS AES and ellipsometry, electrochemical mapping DEIS								
Prerequisites and co-requisites	Good understanding			optics. Comm	unication	n in eng	lish is advice	d.	

Data wydruku: 25.04.2024 17:00 Strona 1 z 2

Assessment methods	Subject passing criteria	Passing threshold	Percentage of the final grade			
and criteria		60.0%	40.0%			
		60.0%	50.0%			
		60.0%	10.0%			
Recommended reading	Basic literature	R. Feynmann, Feynmana wykłady z fizyki. T. 1, cz. 2, PWN, Warszawa, 2012 R. Kelsall, I. Hamley, M. Geoghegan, Nanotechnologie, PWN, Warszawa, 2008 J. Watts, J. Wolstenholme, Surface analysis by XPS and AES, Wiley, New York, 2003				
	Supplementary literature	articles from JCR list,				
		materlas from http://www.e-korozja.pl				
	eResources addresses	Adresy na platformie eNauczanie:				
Example issues/ example questions/ tasks being completed	Use of various microscopes,					
	elimination of image defects,					
	Improvement of resolution and contrast					
	Sample preparation					
	Selection of technique for given samples					
Work placement	Not applicable					

Data wydruku: 25.04.2024 17:00 Strona 2 z 2